IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of:

TOSHISHIGE SHIMAMURA, ET AL.

Art Group:

Application No.:

Examiner:

Filed:

For: **BIOMETRIC RECOGNITION**

APPARATUS

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure, enclosed is a copy of IDS Citation Form PTO/SB/08 or PTO-1449, together with copies of the documents cited on that form, except for copies not required to be submitted (e.g., copies of U.S. patents and U.S. published patent applications need not be enclosed), which are being submitted concurrently with the Utility Application. It is respectfully requested that the cited references be considered and that the enclosed copy of PTO/SB/08 be initialed by the Examiner to indicate such consideration and a copy thereof returned to applicant(s).

DT12 Rec'd PCT/PTO 0 7 JAN 2005

The submission of this Information Disclosure Statement is not to be construed as a representation that a search has been made in the subject application and is not to be construed as an admission that the information cited in this statement is material to patentability.

Please charge any fees due to Deposit Account 02-2666. A duplicate copy of the Fee Transmittal (PTO/SB/17) is enclosed for this purpose.

Respectfully submitted,

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PTO/SB/08A&B (modified) DT12 Rec'd PCT/PTO 0 7 JAN 2005 **Application Number** Substitute for form 1449A&B/PTO INFORMATION DISCLOSURE Filing Date STATEMENT BY APPLICANT First Named Inventor Toshishige Shimamura (use as many sheets as necessary) Art Unit **Examiner Name** 096790. P478 1 1 **Attorney Docket Number** Sheet of

			U.S.P.	ATENT DOCUMEN	IT
Examiner Initials*	Cite No.¹	Document Number		Publication Date	Name of Patentee or Applicant
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Examiner Initials*	Cite No.¹	Foreign Patent Document			Publication Date	Name of Patentee or Applicant of	Tranlation ⁶
		Country Code ³	Number⁴	KindCode ⁵	MM-DD-YYYY	Cited Document	
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